United States Patent [19]

Podhrasky

Patent Number: Des. 297,221

Date of Patent: ** Aug. 16, 1988 [45]

[54]		WALK-THROUGH METAL DETECTOR	
	[75]	Inventor:	Robert J. Podhrasky, Dallas, Tex.
	[73]	Assignee:	Garrett Electronics, Inc., Garland, Tex.
	[**]	Term:	14 Years
	[21]	Appl. No.:	792,295
	[52]	U.S. Cl	Oct. 28, 1985

[56] **References Cited**

U.S. PATENT DOCUMENTS

3,818,472 6/1974 Mauk et al. 340/572

OTHER PUBLICATIONS

Sentrie AT Security System offered by DelNorte Security Systems.

Metor 118.

Sirch-Gate, IV Model SMD20000HD.

Sirch-Gate III Model SMD2000W.

Federal Labs CheckGates Model Nos. 6080, 6080HD, 6085 and 6090.

Sirchie Model SMD 1000W Metal Detection System.

Sirch-Gate (TM) Metal Detection System.

Ion Track Instruments, Inc. Model MD-1 Walk Thru Metal Detector.

Outokumpu Model Metor 118 Walk-through Metal Detector.

Sentrie Model FS 3 General Purpose Metal and Weapons Detector.

Federal Labs Systems Model Checkgate (TM) Walkthrough Metal Detection System.

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[57]

CLAIM

The ornamental design for a walk-through metal detector, as shown.

DESCRIPTION

FIG. 1 is a front perspective view of a walkthrough metal detector showing my new design;

FIG. 2 is a rear perspective view thereof;

FIG. 3 is a top plan view thereof;

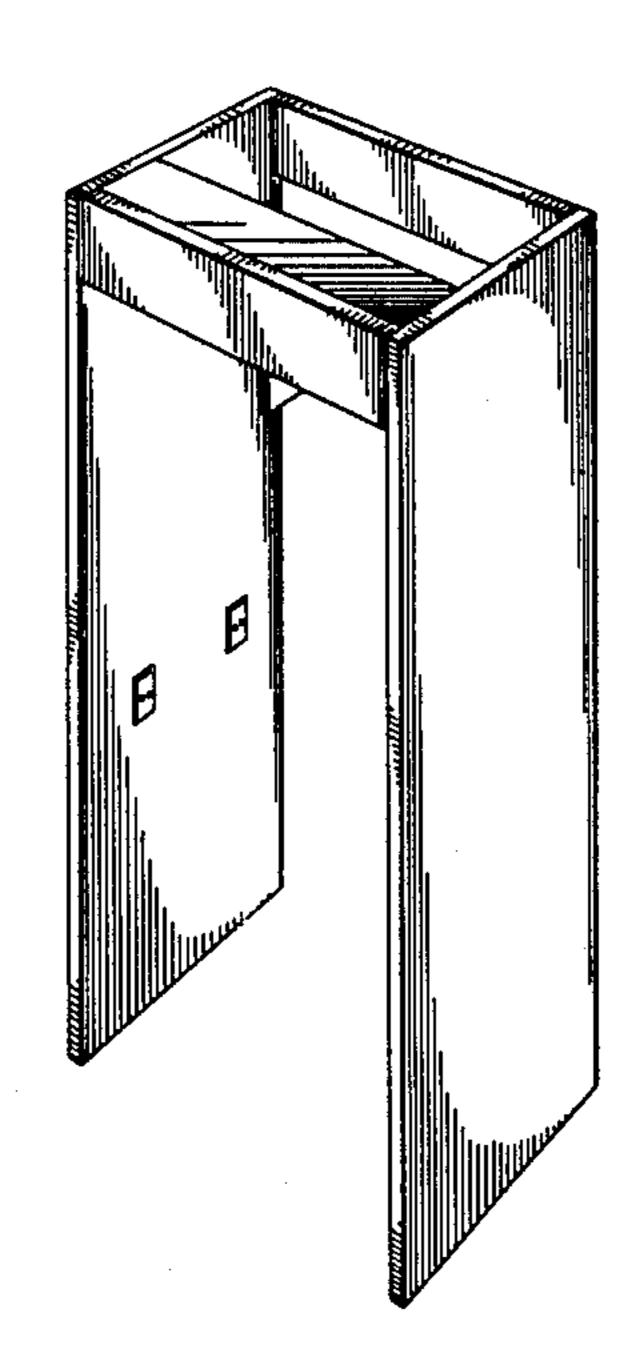
FIG. 4 is a front elevational view thereof;

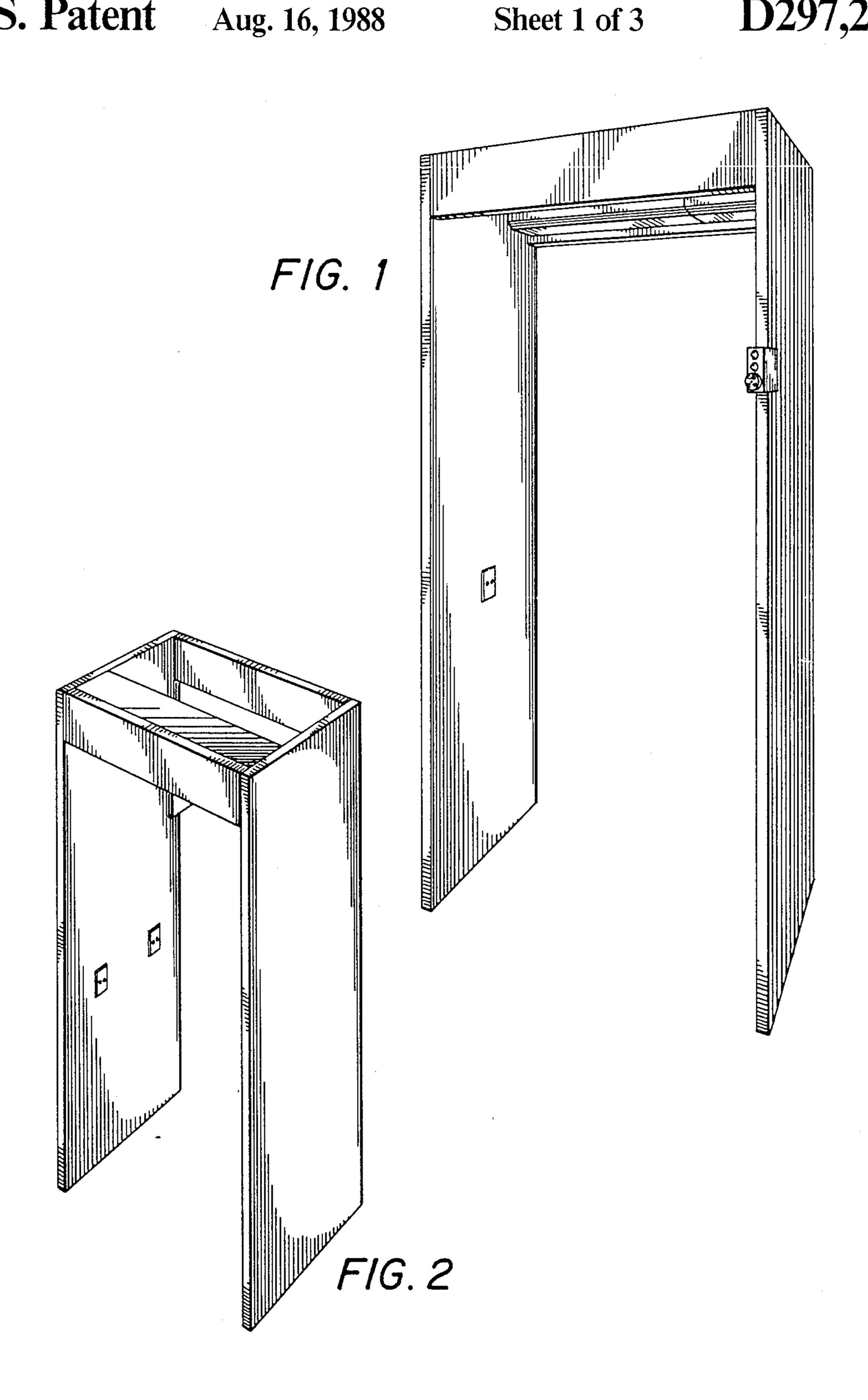
FIG. 5 is a right side elevational view thereof;

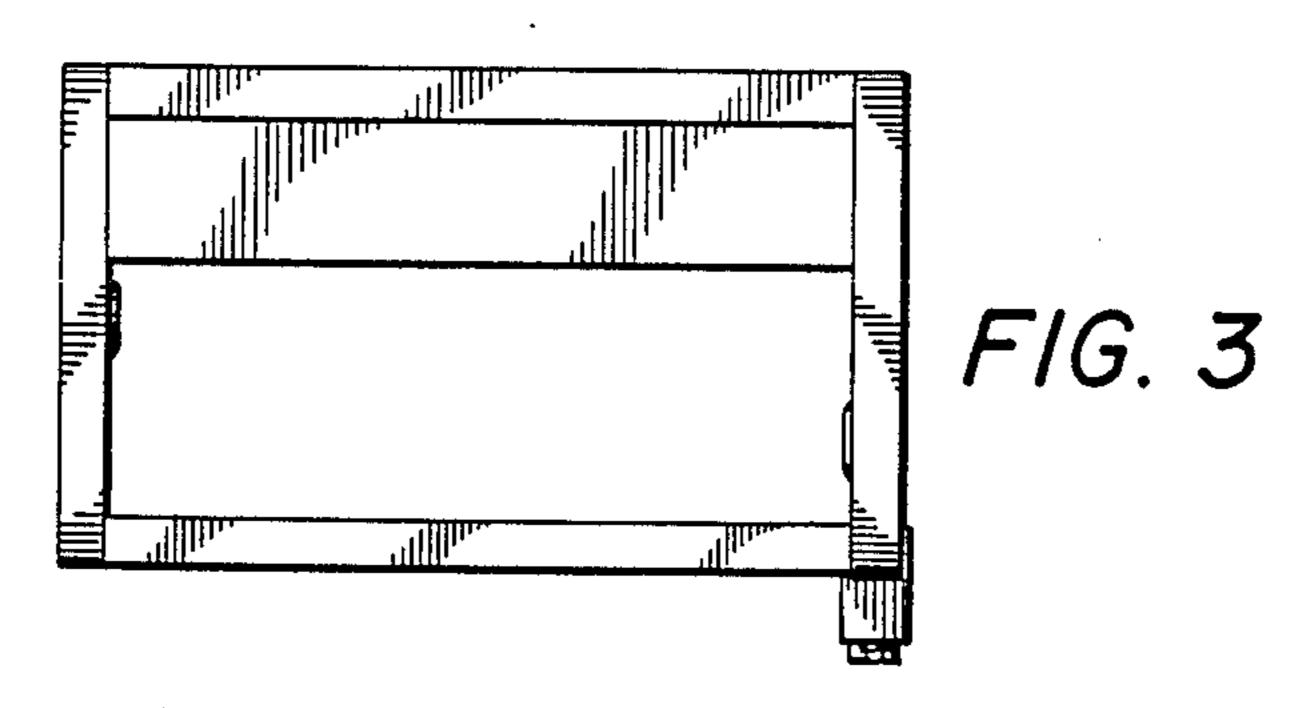
FIG. 6 is a rear elevational view thereof;

FIG. 7 is a left side elevational view thereof; and

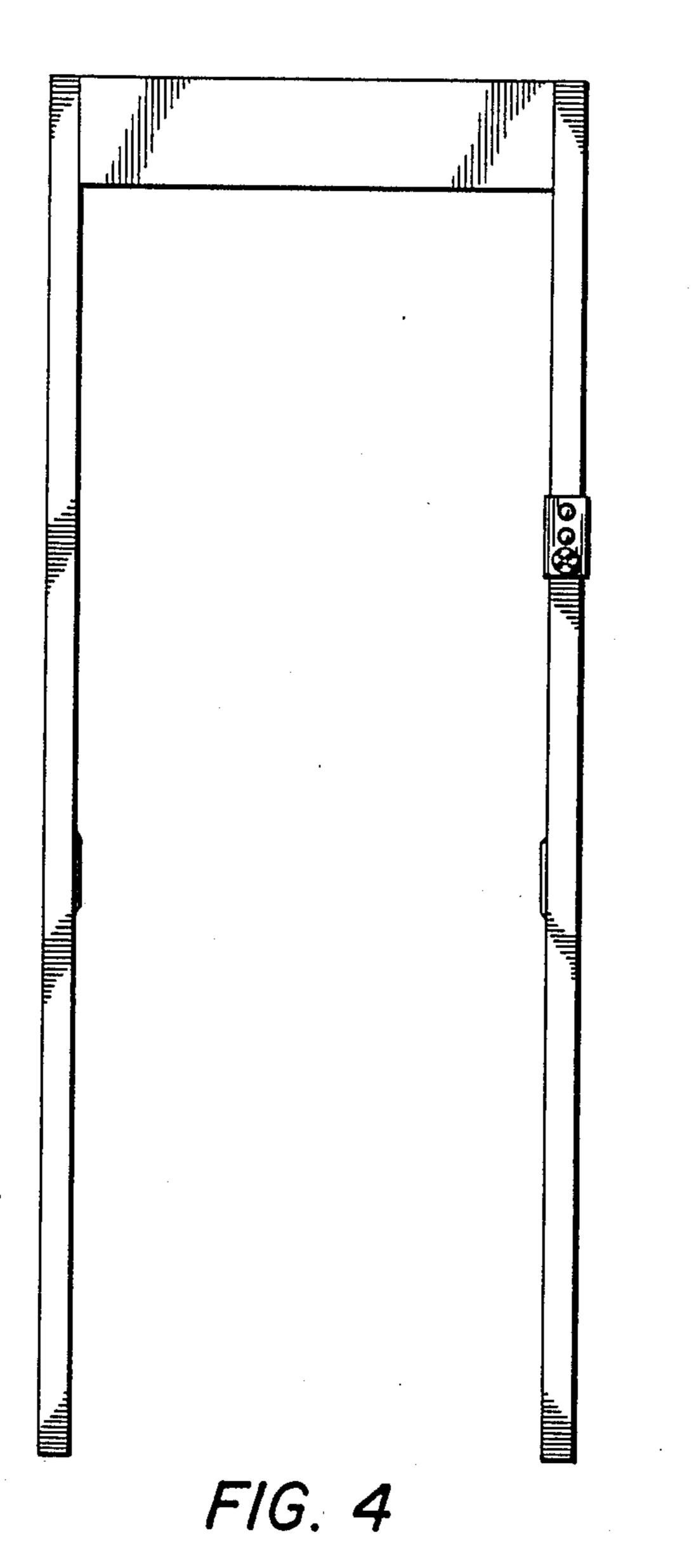
FIG. 8 is a bottom plan view thereof.

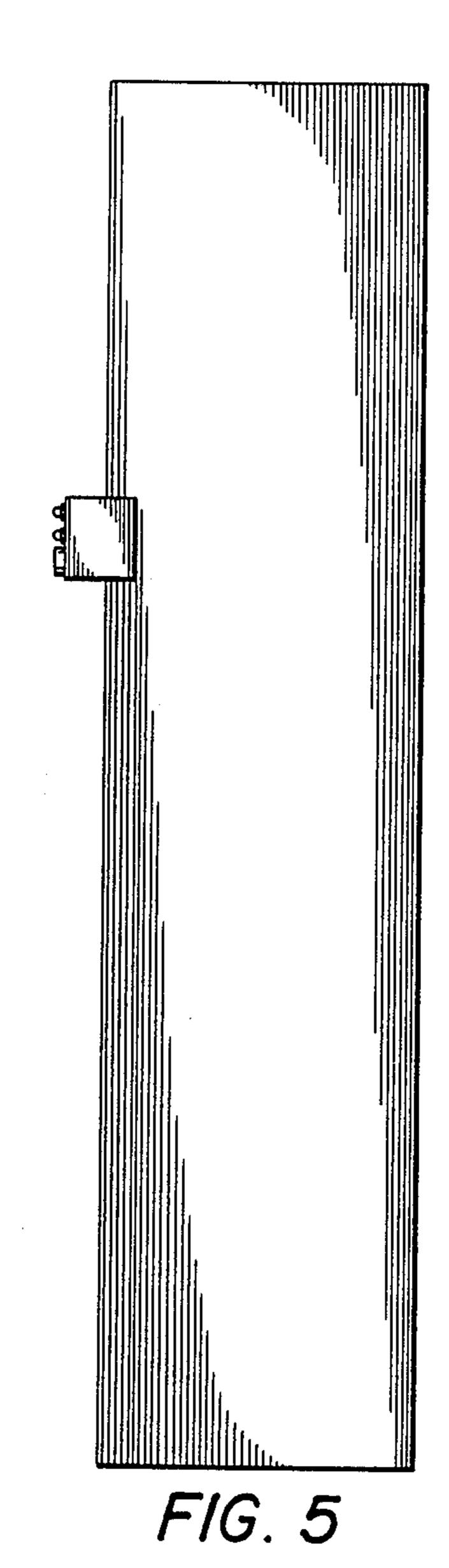


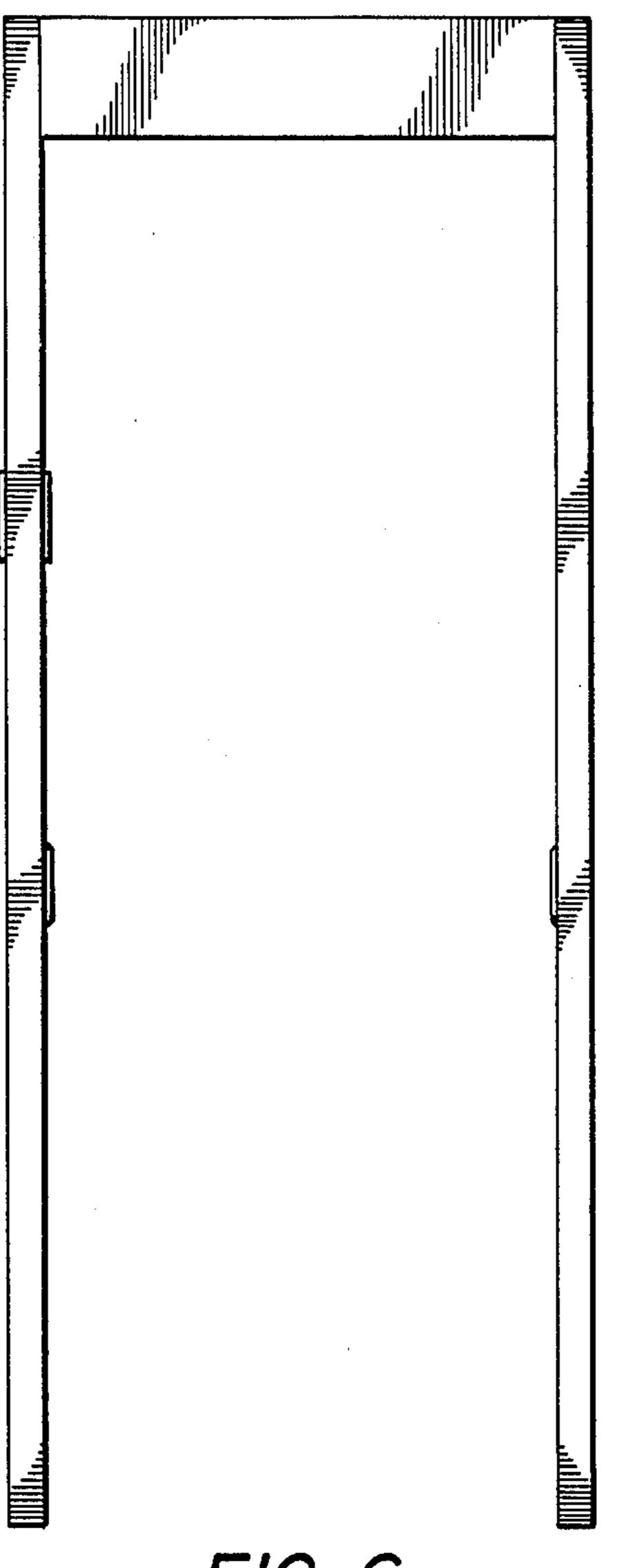




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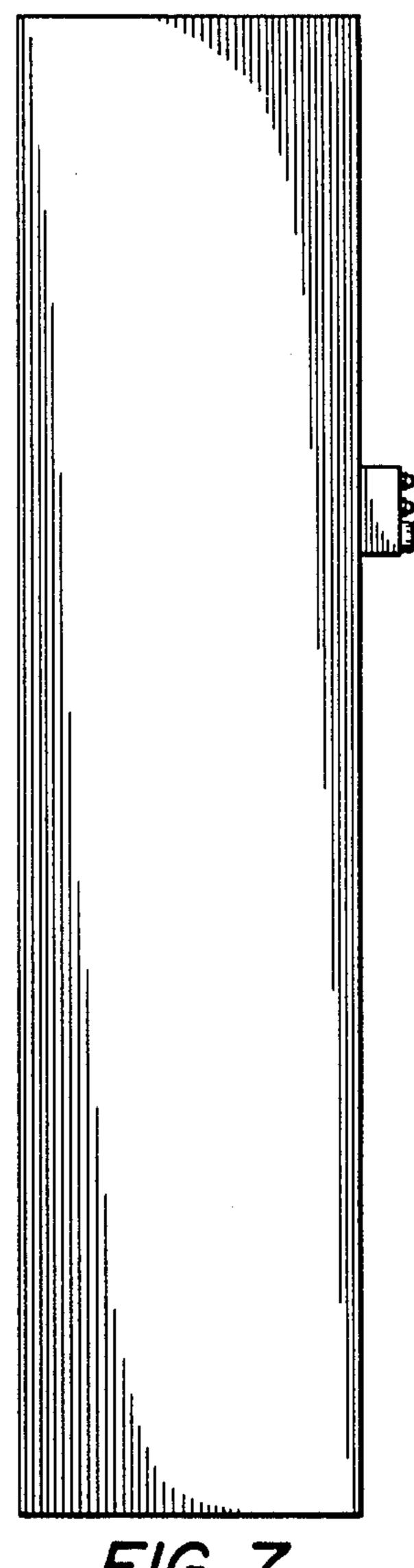






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F/G. 6



F/G. 7

